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AI Day 2021

Object detection for the analysis of creep voids in high-temperature metallic structures

Akhtar Zeb, Mikko Tahkola, Rami Pohja, Janne Pakarinen

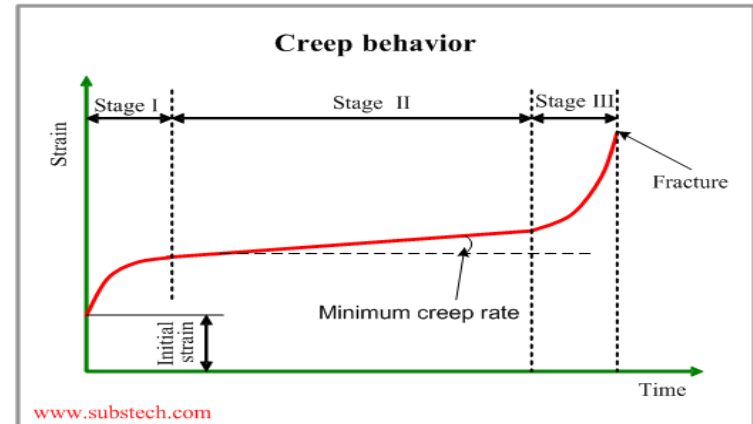
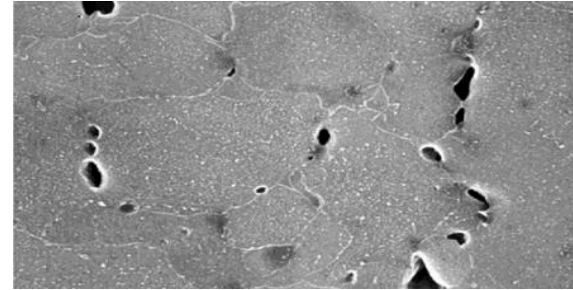
12/01/2022 VTT – beyond the obvious

Problem:

**Creep voids in
metallic structures**

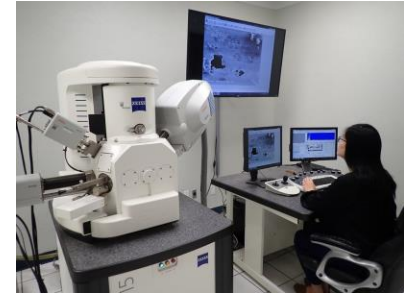
Problem of creep void in metallic structures

- High-temperature metallic structures under load experience creep at temperature about 0.3 times the material's melting temperature
- Creep means significant viscous time-dependent and liquid-like material flows in the direction of principal stress
- Prolonged creep condition leads to rupture and component failure
- At relatively early stages of creep, one important manifestation is the creep void at the grain boundaries of the material
- Reliable and accurate detection of creep void size and density helps in improving the life cycle management of high-temperature components



Creep void analysis – traditional vs machine learning approach

- Creep void inspection in service conditions is usually performed by replica inspection
- Replica inspection samples are taken from components and inspected via optical and/or scanning electron microscope (SEM)
- However, interpretation of the results is often difficult and time-consuming
- ML can help in reducing human errors and speed up the process by analyzing large areas and multiple sample images

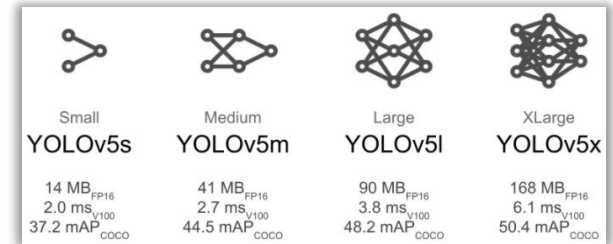


Our solution:

**YOLO object
detection algorithm**

YOLO algorithm

- You Only Look Once
- Object detection algorithm popular for its speed, and outperformed, e.g., *Sliding Window Object Detection*, *R CNN*, *Fast R CNN*, *Faster R CNN* algorithms
- Built on PyTorch framework and tells about object class and object localization, i.e. bounding box
- Makes all the predictions in one forward pass
- Yolo v1, Yolo v2, Yolo v3, Yolo v4, Yolo v5
- **YOLOv5** is a family of object detection architectures and models pretrained on the COCO dataset, and represents *Ultralytics*¹ open-source research into future vision AI methods
- We use the YOLOv5s, which is the smallest and fastest model
- We take advantage of pre-trained weights and default configuration of YOLOv5s



Pretrained Checkpoints

| Model | size (pixels) | mAP ^{val} _{0.5:0.95} | mAP ^{test} _{0.5:0.95} | mAP ^{val} _{0.5} | Speed V100 (ms) | params (M) | FLOPs 640 (B) |
|--------------|---------------|--|---|-----------------------------------|-----------------|------------|---------------|
| YOLOv5s | 640 | 36.7 | 36.7 | 55.4 | 2.0 | 7.3 | 17.0 |
| YOLOv5m | 640 | 44.5 | 44.5 | 63.1 | 2.7 | 21.4 | 51.3 |
| YOLOv5l | 640 | 48.2 | 48.2 | 66.9 | 3.8 | 47.0 | 115.4 |
| YOLOv5x | 640 | 50.4 | 50.4 | 68.8 | 6.1 | 87.7 | 218.8 |
| YOLOv5s6 | 1280 | 43.3 | 43.3 | 61.9 | 4.3 | 12.7 | 17.4 |
| YOLOv5m6 | 1280 | 50.5 | 50.5 | 68.7 | 8.4 | 35.9 | 52.4 |
| YOLOv5l6 | 1280 | 53.4 | 53.4 | 71.1 | 12.3 | 77.2 | 117.7 |
| YOLOv5x6 | 1280 | 54.4 | 54.4 | 72.0 | 22.4 | 141.8 | 222.9 |
| YOLOv5x6 TTA | 1280 | 55.0 | 55.0 | 72.0 | 70.8 | - | - |

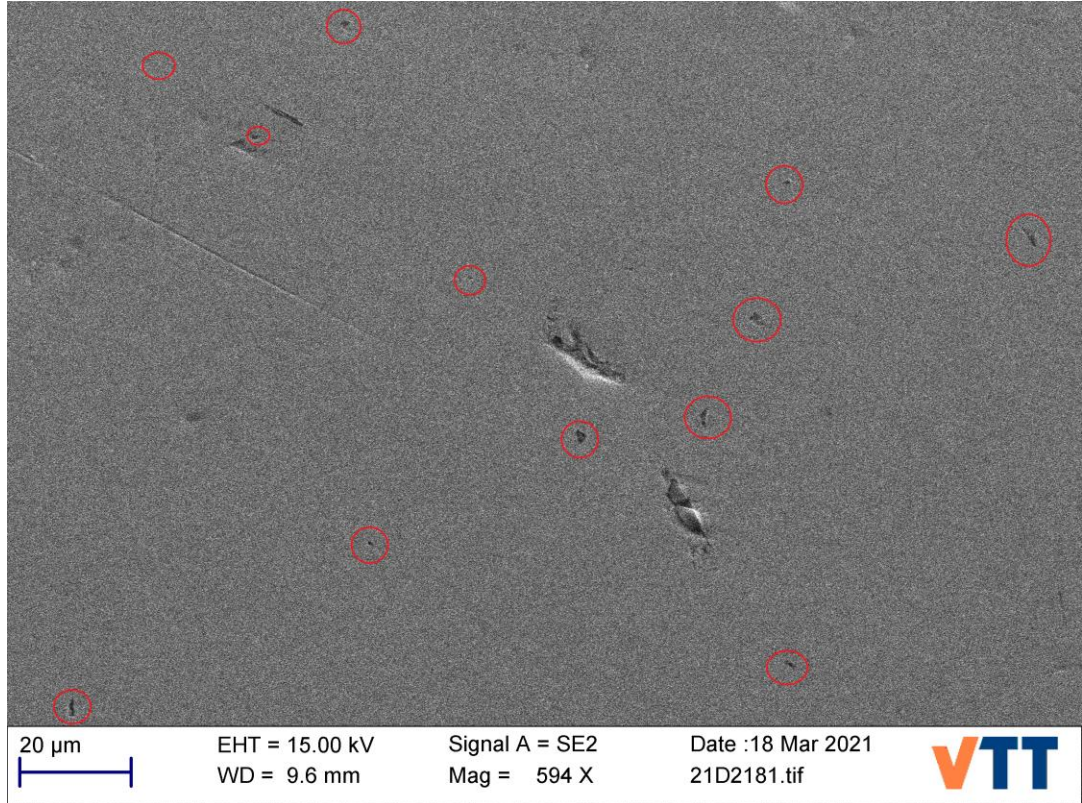
¹<https://ultralytics.com/>

Data:

Scanning electron
microscope images

Scanning electron microscope images

- 100 SEM images of oxygen-free phosphorous doped copper sample surfaces
- With creep voids of different shapes and sizes
- Distinguishing creep voids from other damages could be challenging task even for the material expert

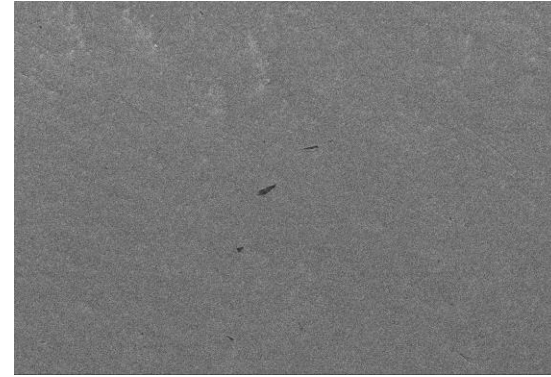
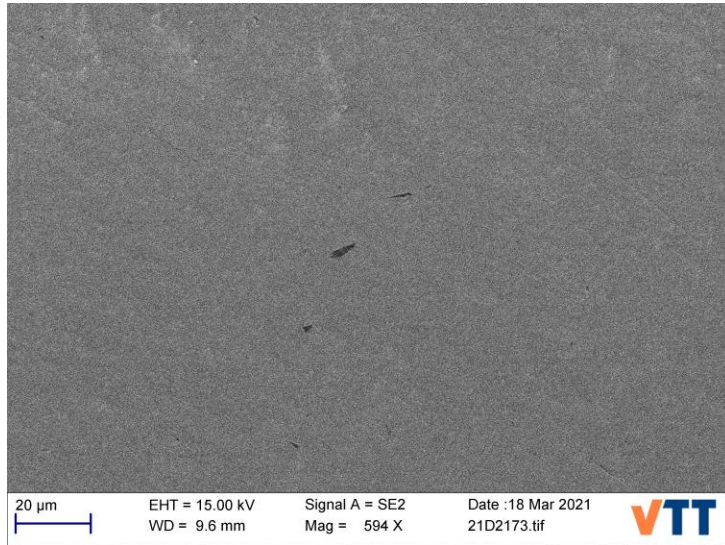


Data pre-processing and annotation

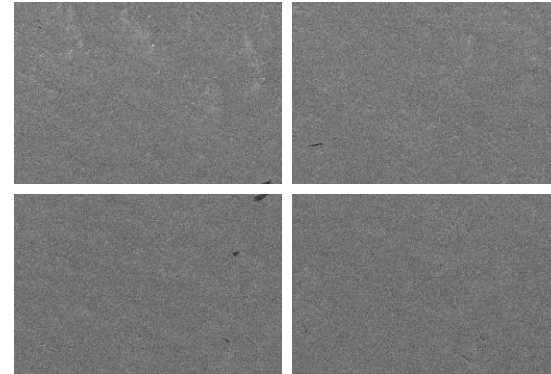
Pre-processing images

- Formatting and cropping
- Resizing
- Splitting

(height, width) (2304, 3072)



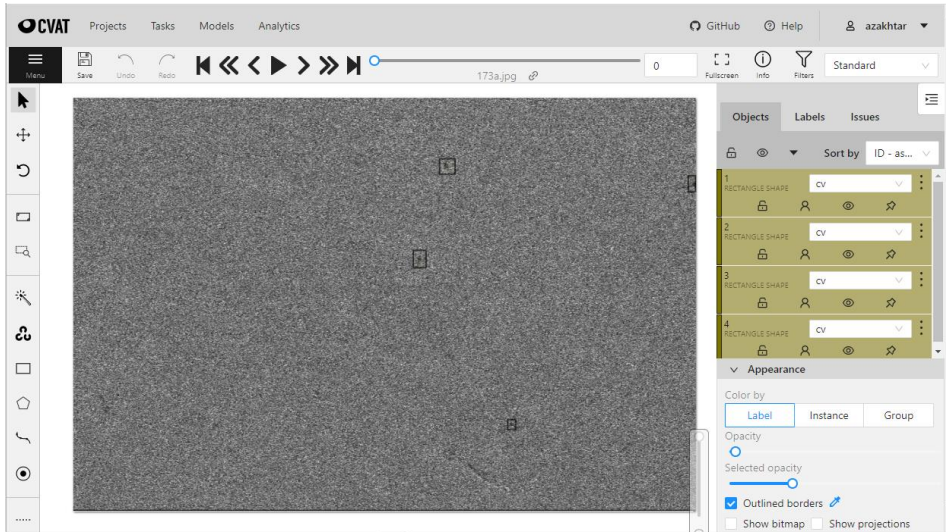
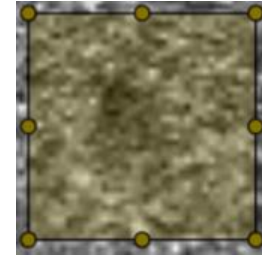
*(height, width)
(2048, 3072)*



*4x
(height, width)
(1024, 1536)*

Labelling and annotation

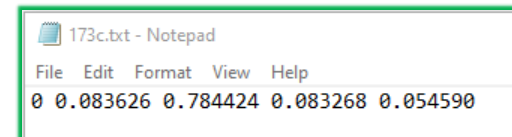
- CVAT – computer vision annotation tool
- Free, online, interactive video and image annotation tool for computer vision
- Supports several annotation formats (coco, yolo, etc.)
- Only one class “cv”, in this study



Yolo format:

Bounding box coordinates are in normalized xywh format (from 0 -1)

Each row is class x center y center width height format



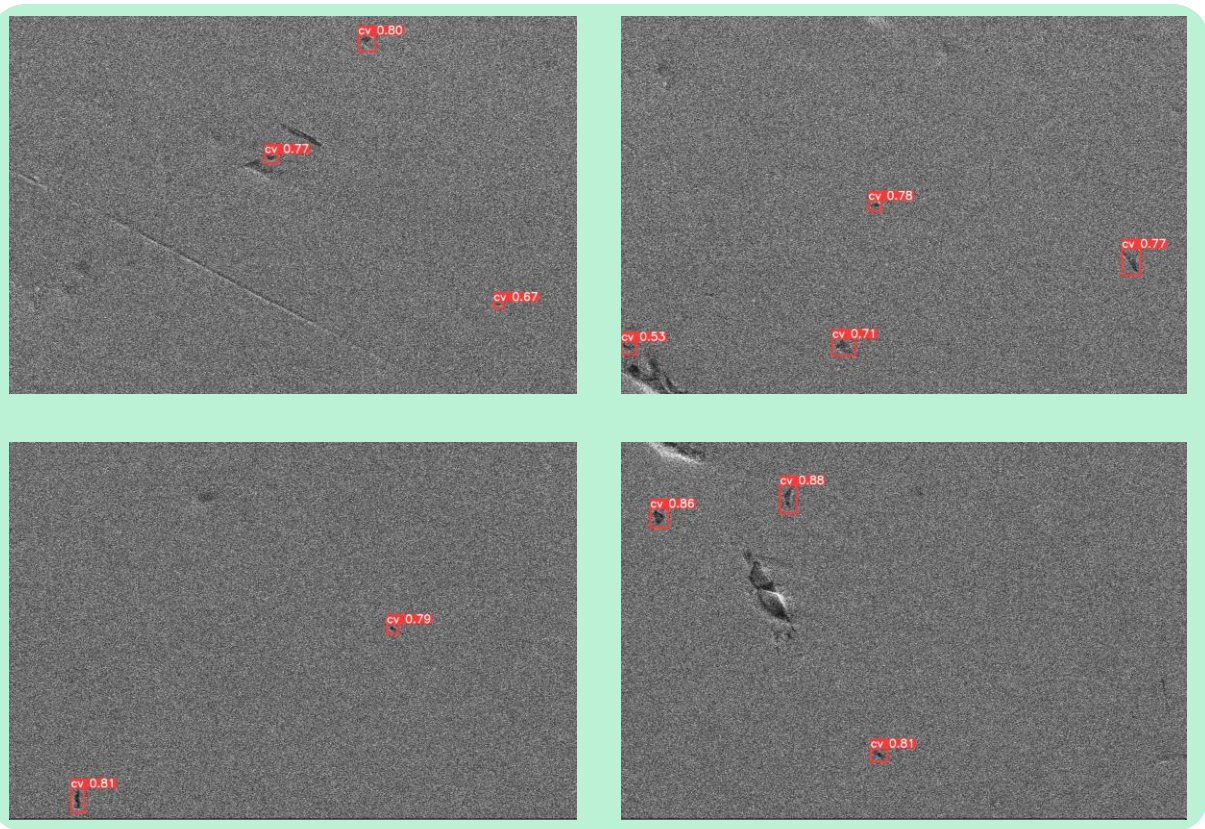
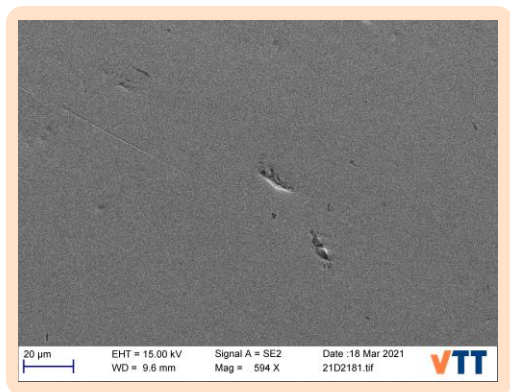
YOLO training, inference, and calculations

Training and results

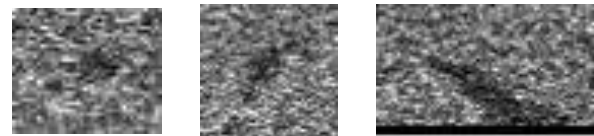
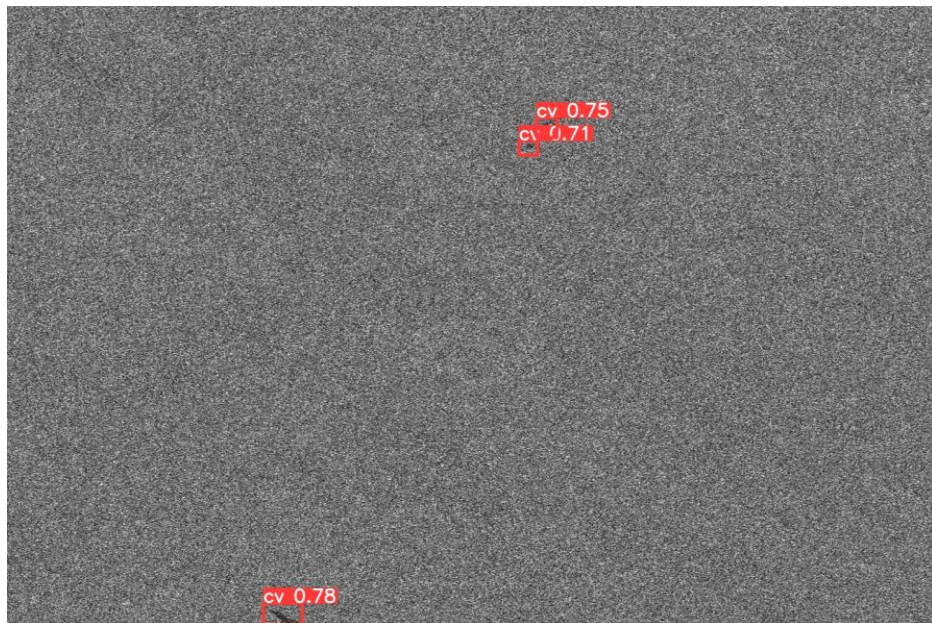
- Google Colab
- Images annotated using CVAT and exported in yolo format
- YOLOv5s model is trained using pretrained weights and default configuration and architecture

| Images | Epochs | Training time | mAP_0.5 |
|--------|--------|---------------|---------|
| 64 | 100 | 45 min | 0.85 |
| 64 | 150 | 1 hour | 0.83 |
| 200 | 100 | 2 hours | 0.82 |

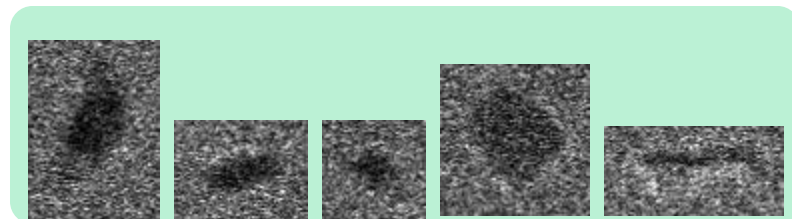
YOLOv5 inference – detections on full-size images



YOLOv5 inference – bounding boxes and creep void images

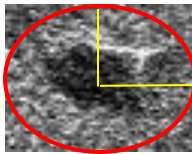
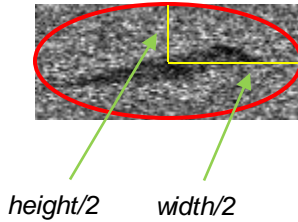


| | xcenter | ycenter | width | height | confidence | class name |
|---|------------|-------------|-----------|-----------|------------|------------|
| 0 | 455.384216 | 1004.244934 | 63.769897 | 35.510864 | 0.779910 | 0 cv |
| 1 | 890.653381 | 200.352341 | 34.046265 | 33.055939 | 0.751255 | 0 cv |
| 2 | 860.605896 | 234.063416 | 30.840942 | 24.863892 | 0.712342 | 0 cv |



Creep void calculations

- $cv_area = \pi \times width/2 \times height/2$
- $cv_num = len(cv_area)$
- $cv_frac_area = \frac{sum(cv_area)}{image(w*h)*100}$



Number of creep-voids in an image: [6, 1, 6, 5, 3, 0, 0, 3]

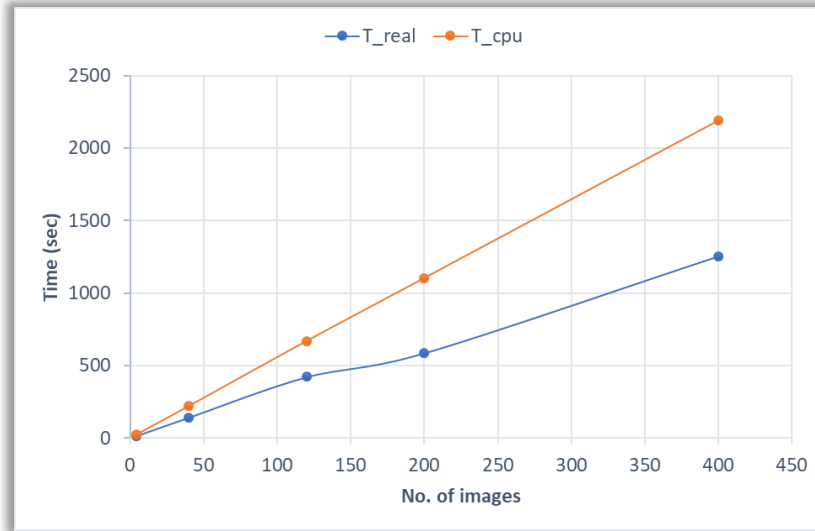
Fractional area (percentage) of (all) creep-voids in an image: [0.3635374031375304, 0.10300326269379431, 0.4792252592922566, 0.21302700214886802, 0.23649661238944594, 0.0, 0.0, 0.14832590684477895]

Area of creep-void in an image:

```
[0 788.529447
1 599.364558
2 1353.928740
3 559.977414
4 550.245897
5 1865.902885
Name: height, dtype: float64, 0 1620.101238
Name: height, dtype: float64, 0 1795.564032
1 1478.330111
2 669.510445
3 2322.489817
4 435.992353
5 835.674824
Name: height, dtype: float64, 0 933.012768
1 960.984515
2 344.420429
3 606.764116
4 505.443199
Name: height, dtype: float64, 0 3111.030319
1 385.109797
2 223.629962
Name: height, dtype: float64, Series([], Name: height, dtype: object), Series([], Name: height, dtype: object), 0 989.901862
1 857.765641
2 485.297288
Name: height, dtype: float64]
```

Inference time

- Total time taken by the algorithm starting from the initial pre-processing of the images to the saving of final results (Intel® Core™ i7-8665U Processor, 16 GB RAM)
- T_real is the system time in seconds from the starting point to the end of a process
- T_cpu is the sum of the system and user CPU time from the beginning to the end of a process



Conclusions

Conclusions and future work

- YOLOv5 built on PyTorch framework
- Easy to train, e.g. using free Google Colab environment including GPUs
- Local installation is straightforward
- Cropped images of the creep voids are obtained, in addition to the detections on full-size images
- Detected all the creep voids correctly
- Bounding boxes coordinates enable calculation of desired parameters
- Labelling accuracy would result in better inferences
- Creep void images can be further investigated using other tools, e.g. ImageJ

bey⁰nd

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